

## **MOSFET**

### CoolSiC™ Power Device 750 V G1

The 750 V CoolSiC<sup>TM</sup> is built over the solid silicon carbide technology developed in Infineon in more than 20 years. Leveraging the wide bandgap SiC material characteristics, the 750V CoolSiC<sup>TM</sup> MOSFET offers a unique combination of performance, reliability and ease of use. Suitable for high temperature and harsh operations, it enables the simplified and cost effective deployment of the highest system efficiency.

### **Features**

- Highly robust 750V technology, 100% avalanche tested
- Best-in-class R<sub>DS(on)</sub> x Q<sub>fr</sub>
- Excellent R<sub>DS(on)</sub> x Q<sub>oss</sub> and R<sub>DS(on)</sub> x Q<sub>G</sub>
- Unique combination of low C<sub>rss</sub>/C<sub>iss</sub> and high V<sub>GS(th)</sub>
- Infineon proprietary die attach technology
- · Driver source pin available

#### **Benefits**

- Enhanced robustness and reliability for bus voltages beyond 500 V
- · Superior efficiency in hard switching
- Higher switching frequency in soft switching topologies
- Robustness against parasitic turn on for unipolar gate driving
- Reduced switching losses through improved gate control

## Potential applications

- · EV charging infrastructure
- Solar PV inverters
- UPS (uninterruptable power supplies)
- · Energy storage and battery formation
- Telecom and Server SMPS

### **Product validation**

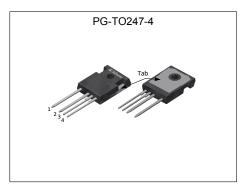
Fully qualified according to JEDEC for Industrial Applications

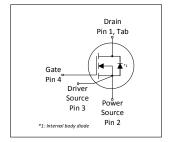
Please note: The source and driver source pins are not exchangeable. Their exchange might lead to malfunction.



Parameter	Value	Unit
$V_{\rm DSS}$ over full $T_{\rm j,range}$	750	V
$R_{\mathrm{DS(on),typ}}$	20	mΩ
R <sub>DS(on),max</sub>	27	mΩ
$Q_{G,typ}$	67	nC
I <sub>DM,max</sub>	261	A
Q <sub>oss,typ</sub> @ 500 V	133	nC
E <sub>oss,typ</sub> @ 500 V	23.9	μJ

Type / Ordering Code	Package	Marking	Related Links
IMZA75R020M1H	PG-TO247-4	75R020M1	see Appendix A











## CoolSiC<sup>™</sup> Power Device 750 V G1 IMZA75R020M1H



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1 Maximum ratings at  $T_j = 25$  °C, unless otherwise specified.

Note: for optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Danamatan	Oala al		Value	s	ļ,	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous DC drain current <sup>1)</sup>	I <sub>DDC</sub>	-	-	75 52	А	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C	
Peak drain current <sup>2)</sup>	I <sub>DM</sub>	-	-	261	Α	T <sub>C</sub> = 25 °C, V <sub>GS</sub> = 18 V	
Avalanche energy, single pulse	<b>E</b> AS	-	-	333	mJ	$I_{\rm D}$ = 12.5 A, $V_{\rm DD}$ = 50 V; see table 11	
Avalanche energy, repetitive pulse	<b>E</b> AR	-	-	1.66	mJ	$I_D$ = 12.5 A, $V_{DD}$ = 50 V; see table 11	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	12.5	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	200	V/ns	V <sub>DS</sub> = 0500 V	
Gate source voltage (static)	V <sub>GS</sub>	-5	-	23	V	-	
Gate source voltage (transient)	V <sub>GS</sub>	-10	-	25	V	$t_p \le 500 \text{ ns, duty cycle} \le 1\%$	
Power dissipation	P <sub>tot</sub>	-	-	278	W	T <sub>C</sub> = 25 °C	
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-	
Operating junction temperature	T <sub>j</sub>	-55	-	175	°C	-	
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws	
Continuous reverse drain current <sup>1)</sup>	I <sub>SDC</sub>	-	-	75 50	А	V <sub>GS</sub> = 18 V, T <sub>C</sub> = 25 °C V <sub>GS</sub> = 0 V, T <sub>C</sub> = 25 °C	
Peak reverse drain current <sup>2)</sup>	I <sub>SM</sub>	-	-	261 83	А	$T_{\rm C}$ = 25 °C, $t_{\rm p}$ ≤ 250 ns $T_{\rm C}$ = 25 °C	
Insulation withstand voltage	V <sub>ISO</sub>	-		n.a.	V	$V_{\rm rms}$ , $T_{\rm C}$ = 25 °C, $t$ = 1 min	

 $<sup>^{1)}</sup>$  Limited by  $T_{\rm J,max}$   $^{2)}$  Pulse width  $t_{\rm P}$  limited by  $T_{\rm j,max}$ 



### 2 Thermal characteristics

**Table 3** Thermal characteristics

Developed	Cy made al	Values			11:4	Nata (Table Caralitica)	
Parameter	Symbol	Min.	Тур.	Max. Unit		Note / Test Condition	
Thermal resistance, junction - case	R <sub>th(j-c)</sub>	-	-	0.54	°C/W	Not subject to production test. Parameter verified by design/characterization according to JESD51-14.	
Soldering temperature, wave soldering only allowed at leads	$T_{sold}$	-	-	260	°C	1.6mm (0.063 in.) from case for 10s	

## 3 Operating range

**Table 4** Operating range

Doromotor	Cymbol	Values			11	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Gate-source voltage operating range including undershoots <sup>1)</sup>	$V_{\mathrm{GS}}$	-2	-	20	V	-	
Recommended turn-on voltage	V <sub>GS(on)</sub>	-	18	-	V	-	
Recommended turn-off voltage	V <sub>GS(off)</sub>	-	0	-	V	-	

<sup>&</sup>lt;sup>1)</sup> **Important notice:** If the gate source voltage of the device in application exceeds the operating range (Table 4), the device  $R_{DS(on)}$  and  $V_{GS(th)}$  might exceed the maximum value stated in the datasheet at the end of the lifetime of the device. In order to ensure sound operation of the device over the planned lifetime, the maximum ratings (Table 2) and the application note AN2018-09 must be considered.



## **Electrical characteristics**

at  $T_i$  = 25 °C, unless otherwise specified

Table 5 Static characteristics

Downworton	Combal		Values			Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source voltage <sup>1)</sup>	V <sub>DSS</sub>	750	-	-	V	$V_{GS} = 0 \text{ V}, I_D = 1.17 \text{ mA},$ $T_j = -55 \text{ °C to } 175 \text{ °C}$
Gate threshold voltage <sup>2)</sup>	V <sub>GS(th)</sub>	3.5	4.3	5.6	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 11.7 \text{ mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	1 10	75 -	μΑ	$V_{\rm DS}$ = 750 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 25 °C $V_{\rm DS}$ = 750 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 175 °C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	- - -	25 20 18 36	- 27 - -	mΩ	$V_{\rm GS}$ = 15 V, $I_{\rm D}$ = 32.5 A, $T_{\rm j}$ = 25 °C $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $T_{\rm j}$ = 25 °C $V_{\rm GS}$ = 20 V, $I_{\rm D}$ = 32.5 A, $T_{\rm j}$ = 25 °C $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $T_{\rm j}$ =175 °C
Internal gate resistance	R <sub>G,int</sub>	-	3	-	Ω	f = 1 MHz

#### Table 6 **Dynamic characteristics**

External parasitic elements (PCB layout) influence switching behavior significantly.

Stray inductances and coupling capacitances must be minimized.

For layout recommendations please use provided application notes or contact Infineon sales office.

Barrantan	Ols al	Values			11	Nata / Table Operation	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	2217	-	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}, f = 250 \text{ kHz}$	
Reverse transfer capacitance	C <sub>rss</sub>	-	14	-	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}, f = 250 \text{ kHz}$	
Output capacitance <sup>3)</sup>	Coss	-	149	193	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V}, f = 250 \text{ kHz}$	
Output charge <sup>3)</sup>	Qoss	-	133	173	nC	calculation based on Coss	
Effective output capacitance, energy related <sup>4)</sup>	C <sub>o(er)</sub>	-	191	-	pF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0500 V	
Effective output capacitance, time related <sup>5)</sup>	C <sub>o(tr)</sub>	-	267	-	pF	$I_D$ = constant, $V_{GS}$ = 0 V, $V_{DS}$ = 0500 V	
Turn-on delay time	t <sub>d(on)</sub>	-	13	-	ns	$V_{\rm DD}$ = 500 V, $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $R_{\rm G}$ = 1.8 $\Omega$ ; see table 10	
Rise time	t <sub>r</sub>	-	15	-	ns	$V_{\rm DD}$ = 500 V, $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $R_{\rm G}$ = 1.8 $\Omega$ ; see table 10	
Turn-off delay time	$t_{\sf d(off)}$	-	29	-	ns	$V_{\rm DD}$ = 500 V, $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $R_{\rm G}$ = 1.8 $\Omega$ ; see table 10	
Fall time	t <sub>f</sub>	-	9	-	ns	$V_{\rm DD}$ = 500 V, $V_{\rm GS}$ = 18 V, $I_{\rm D}$ = 32.5 A, $R_{\rm G}$ = 1.8 $\Omega$ ; see table 10	

<sup>&</sup>lt;sup>1)</sup> Tested at  $T_j$  = 25 °C, minimum  $V_{DSS}$  verified by design over full junction temperature range.

<sup>2)</sup> Tested after 1 ms pulse at  $V_{GS}$  = +20 V. "Linear mode" operation is not recommended. For assessment of potential "linear mode" operation, please contact Infineon sales office.

<sup>3)</sup> Maximum specification is defined by calculated six sigma upper confidence bound.

 $<sup>^{4)}</sup>$   $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 500 V. <sup>5)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 500 V.

# CoolSiC<sup>™</sup> Power Device 750 V G1 IMZA75R020M1H



 Table 7
 Gate charge characteristics

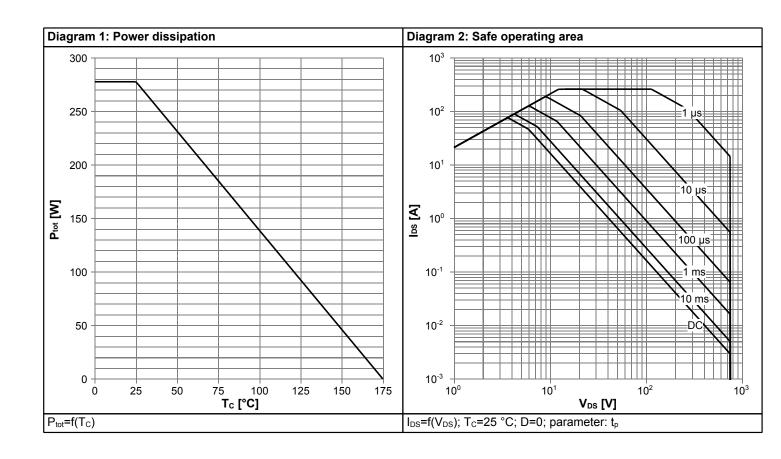
Parameter	Cumbal	Values			Unit	Note / Test Condition	
raiametei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Plateau gate to source charge	Q <sub>GS(pl)</sub>	_	18	-	nC	$V_{DD}$ = 500 V, $I_{D}$ = 32.5 A, $V_{GS}$ = 0 to 18 V	
Gate to drain charge	$Q_{GD}$	_	17	-	nC	$V_{DD}$ = 500 V, $I_{D}$ = 32.5 A, $V_{GS}$ = 0 to 18 V	
Total gate charge	$Q_G$	_	67	-	nC	$V_{DD}$ = 500 V, $I_{D}$ = 32.5 A, $V_{GS}$ = 0 to 18 V	

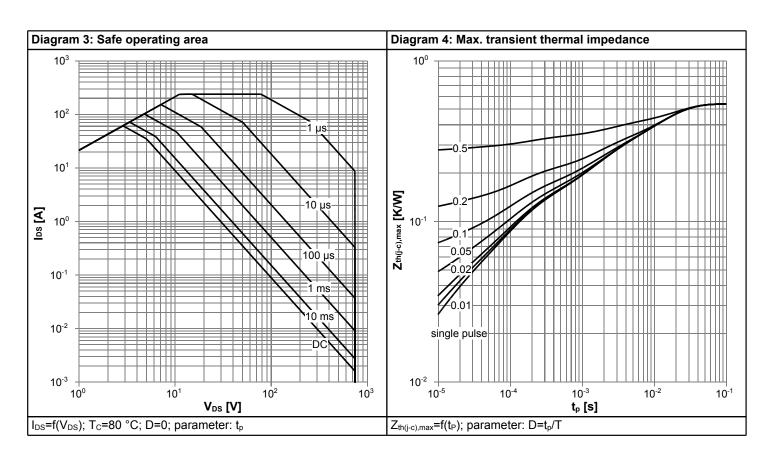
### Table 8 Reverse diode characteristics

Parameter	0	Values			Unit		
Parameter	Symbol	Min.	Тур.	Тур. Мах.		Note / Test Condition	
Drain-source reverse voltage	V <sub>SD</sub>	-	3.9	5.3	V	$V_{GS} = 0 \text{ V}, I_{S} = 32.5 \text{ A}, T_{j} = 25 \text{ °C}$	
MOSFET forward recovery time	t <sub>fr</sub>	-	23 15	-	ns $V_{DD} = 500 \text{ V}, I_{S} = 32.5 \text{ A},$ $di_{S}/dt = 1000 \text{ A/µs}; \text{ see table } 9$ $V_{DD} = 500 \text{ V}, I_{S} = 32.5 \text{ A},$ $di_{S}/dt = 4000 \text{ A/µs}; \text{ see table } 9$		
MOSFET forward recovery charge <sup>1)</sup>	Q <sub>fr</sub>	-	135 212	-	nC	$V_{\rm DD}$ = 500 V, $I_{\rm S}$ = 32.5 A, $di_{\rm S}/dt$ = 1000 A/µs; see table 9 $V_{\rm DD}$ = 500 V, $I_{\rm S}$ = 32.5 A, $di_{\rm S}/dt$ = 4000 A/µs; see table 9	
MOSFET peak forward recovery current	I <sub>frm</sub>	-	12 29	-	A	$V_{\rm DD}$ = 500 V, $I_{\rm S}$ = 32.5 A, $di_{\rm S}/dt$ = 1000 A/µs; see table 9 $V_{\rm DD}$ = 500 V, $I_{\rm S}$ = 32.5 A, $di_{\rm S}/dt$ = 4000 A/µs; see table 9	

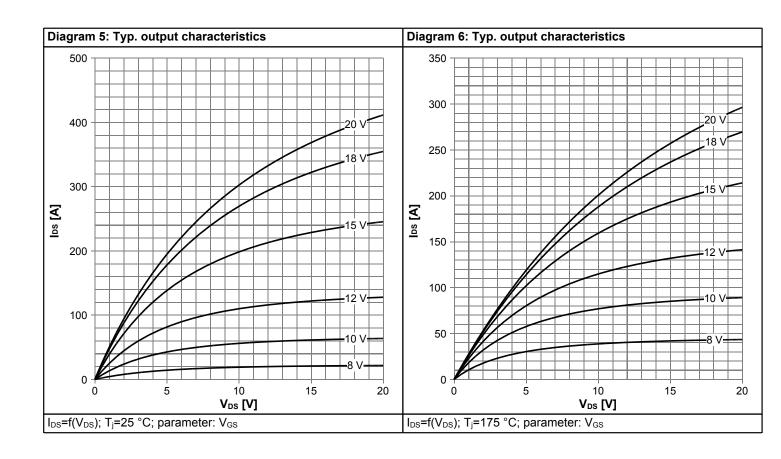


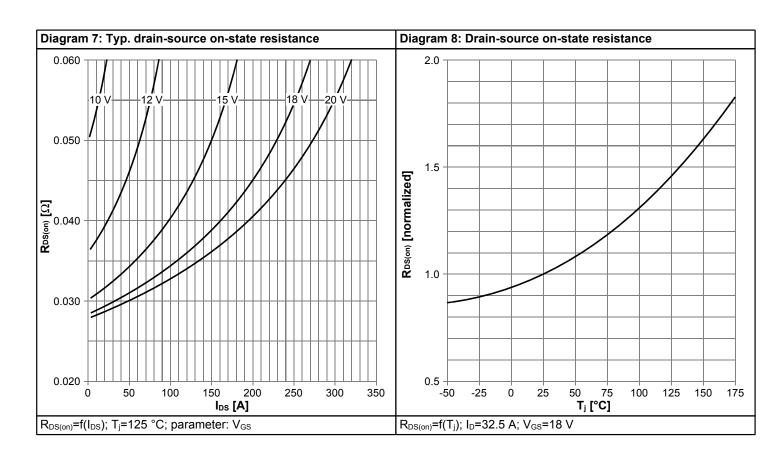
## 5 Electrical characteristics diagrams



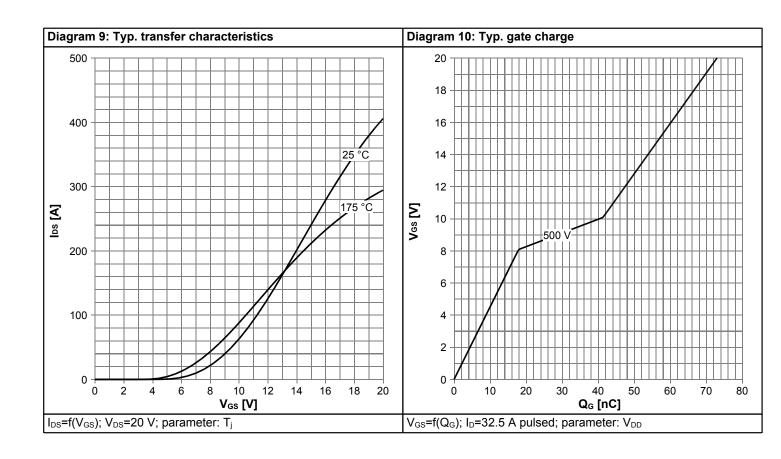


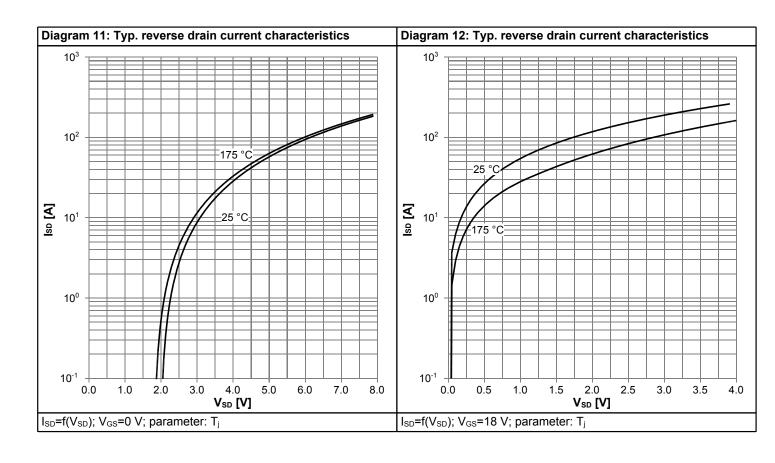




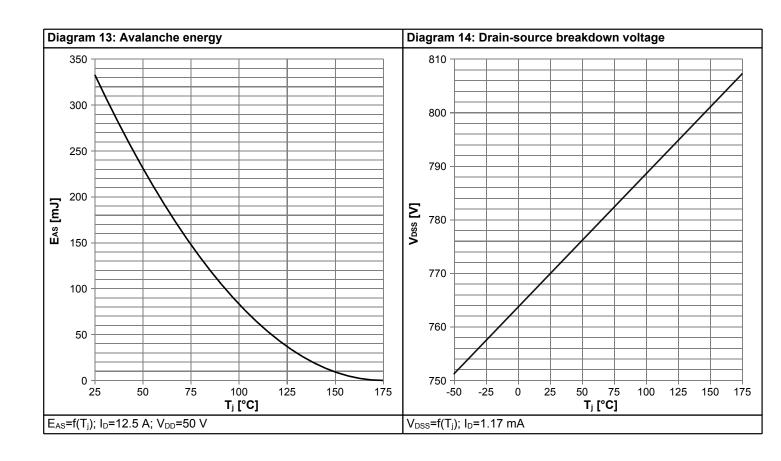


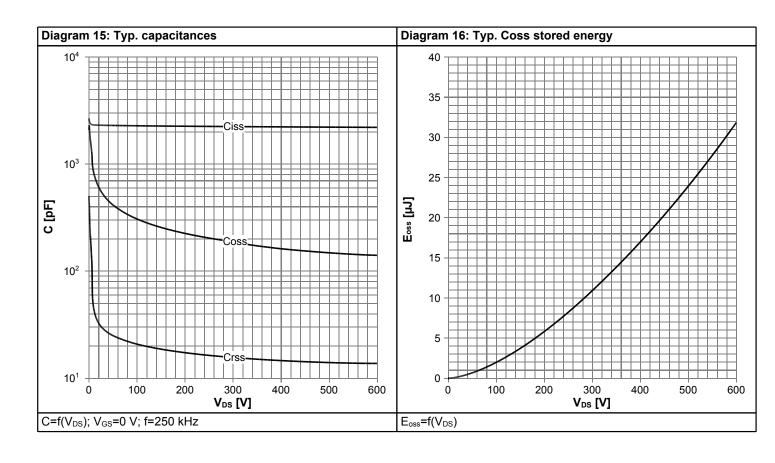




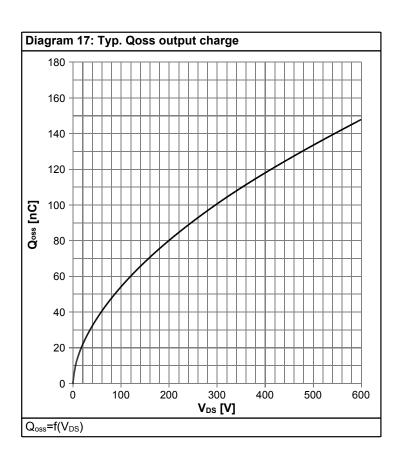














## 6 Test Circuits

Table 9 Body diode characteristics

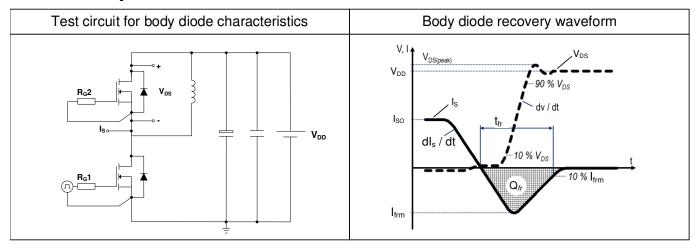


Table 10 Switching times

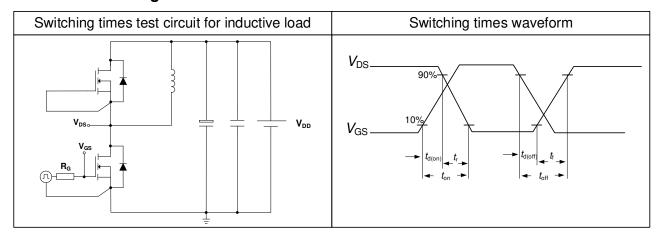
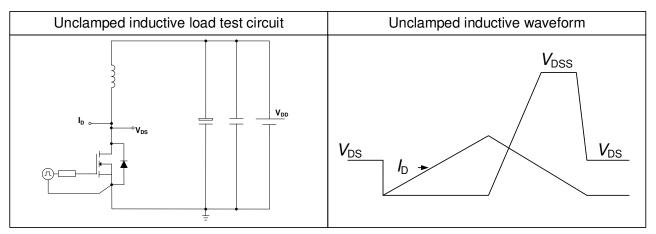
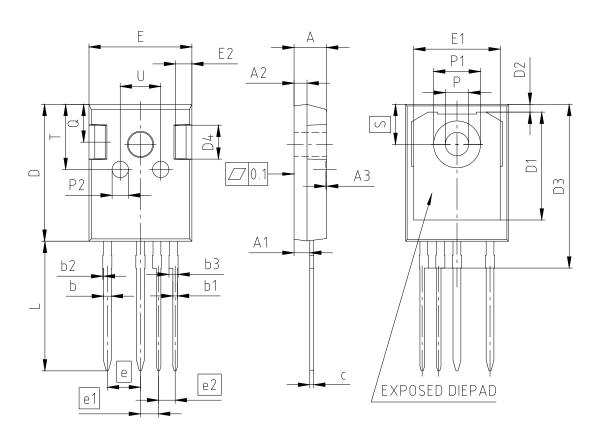


Table 11 Unclamped inductive load





# 7 Package Outlines



NOTES:
DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

PACKAGE - GROUP NUMBER:	DC= 177947-4-1109				
DIMENSIONS	MILLIM	IETERS	DIMENSIONS	MILLIM	ETERS
DIMENSIONS	MIN.	MAX.	DIMENSIONS	MIN.	MAX.
Α	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.05	0.25	е	5.0	08
b	1.10	1.30	e1	2.79	
b1	0.65	0.79	e2	2.54	
b2		0.20	N	4	
b3	1.34	1.44	L	19.80	20.10
С	0.58	0.66	øΡ	3.50	3.70
D	20.90	21.10	øP1	7.00	7.40
D1	16.25	16.85	øP2	2.40	2.60
D2	1.05	1.35	Q	5.60	6.00
D3	24.97	25.27	S	6.	15
D4	4.90	5.10	Т	9.80	10.20
			U	6.00	6.40

Figure 1 Outline PG-TO247-4, dimensions in mm



## 8 Appendix A

### Table 12 Related Links

- IFX CoolSiC™ Power Device 750 V G1 Webpage: www.infineon.com
- IFX CoolSiC™ Power Device 750 V G1 application note: www.infineon.com
- IFX CoolSiC™ Power Device 750 V G1 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com

# CoolSiC<sup>™</sup> Power Device 750 V G1 IMZA75R020M1H



#### **Revision History**

IMZA75R020M1H

Revision: 2024-01-30, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2024-01-30	Release of final version

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